Design of a multispectral imaging system for detecting mildew damage on wheat kernels

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Abstract. Mildew fungus imparts a grey discolouration on wheat kernels causing a loss in value of grain. Mildewed kernels in a wheat shipment are undesirable as they have a negative impact on flour colour. In an earlier study (Shahin et al. 2009), we found that hyperspectral imaging (HSI) in the 400-1000 nm range could be used for predicting mildew levels in wheat samples, however, the HSI system has little practical value due to prohibitively high cost of the system. The objective of this study was to design a low cost multispectral system. A set of 4 key wavelengths was identified which performed equally well as the full-spectrum HSI system. Computer simulations of optical filters characteristics showed a close match between the simulated multispectral and the target hyperspectral data at selected wavelengths with an error of less than 1%. Hardware implementation and performance evaluation of the proposed low cost system is planned next.

Keywords. Hyperspectral, multispectral, wheat, mildew.
INTRODUCTION

Mildew is a serious degrading factor especially in the Eastern Canadian wheat classes (Dexter and Edwards 1998). Mildew fungus imparts a grey discolouration on wheat kernels causing a loss in value of grain. Mildewed kernels in a wheat shipment are undesirable as they have a negative impact on flour colour. Flour milling performance is lower because flour is darker. There is an increase in the negative impact on flour colour with increasing infection by mildew spores. Severely damaged kernels can be identified through human inspection; however, quantification of the extent of mildew damage through visual inspection remains a challenge. The grain industry requires fast and accurate objective methods for detection and quantification of mildew damage to meet the needs of national as well as international trade.

The identification of mildew damaged regions of kernels by imaging appears to be a logical solution, however, conventional imaging instrumentation lacks the ability to measure material composition through spectral analysis. On the other hand, conventional spectroscopy which is commonly used to assess composition of agricultural commodities through spectral analysis lacks in spatial information. As a remedy to this situation, hyperspectral imaging combines the complementary approaches of spectral analysis and image processing, thus offering the potential for defect recognition and quantification of their magnitude. As hyperspectral hardware has advanced over the past 10 years and computer processing speed has risen, the popularity of hyperspectral image analysis has grown in the agricultural and food research community. Hyperspectral imaging applications have been reported for quality assessment of fruits (Kim et al. 2002, Lu 2003), vegetables [Chang et al. 2004, Gowen et al. 2008], poultry (Park et al. 2002), beef steaks (Naganathan et al. 2008) and cereal grains (Cogdill et al. 2004, Lin et al. 2006, Goretta et al. 2006, Shahin and Symons 2008). Recent studies have shown that hyperspectral imaging could distinguish sprout damaged (Singh et al. 2009, Xing et al. 2009) as well as stained and fungal infected (Berman et al. 2007, Singh et al. 2007) wheat kernels from sound kernels. Spectral characteristics of mildewed wheat kernels have been reported to be significantly different from those of sound undamaged kernels (Shahin and Symons 2007).

Hyperspectral imaging is often used as a precursor to developing dedicated multispectral machine vision systems where useful wavelengths are identified through hyperspectral image analysis that can be packaged in a dedicated multispectral image analysis inspection system. In a recent study, Shahin et al (2009) has investigated the use of hyperspectral imaging in the visible/near-infrared wavelength range to assess the amount of mildew damage in wheat samples. Spectra over the 450-950 nm range was used to develop PLS models that predicted mildew levels with an $R^2$ of 0.9 in comparison with the visual inspection scores. This system in its present form has little practical value due to prohibitively high cost of the system. The objectives of this study were: (a) to select a set of 3-5 important wavelengths capable of achieving a similar performance for predicting mildew levels in wheat samples, and (b) to investigate through simulation if the selected wavelengths can be packaged as a low cost multispectral imaging system without compromising the performance. The design and implementation issues of a low cost system are discussed in this paper.

MATERIAL AND METHODS

In an earlier study (Shahin et al. 2009), 65 samples of CESRW were analysed for mildew damage with a hyperspectral imaging system in the 400-1000nm range. They developed PLS models using the spectra from 450-950nm range to predict mildew levels in comparison with inspectors’ visual scores on a scale of 1-9, where 1 represented top of grade 1 and 9 represented bottom of grade 3.

In this study, regression coefficients of the best PLS model of Shahin et al. (2009) were investigated to select a set of 3-5 most important wavelengths (Fig 1). Using the selected
wavelengths, a PLS model was re-developed for predicting mildew levels, and results were compared with those of the full wavelength range model (Table 1) in terms of coefficient of determination ($R^2$) and root-mean-squared-error (RMSE).

Computer simulation of a multispectral system was implemented with a computer program written in IDL (Version 7.0.2; ITT Visual Information Solutions, Denver, CO, USA) which modeled the characteristics of optical filters to generate images at selected wavelengths from previously scanned hyperspectral images. To check for spectral similarity, simulated images were compared on a pixel-by-pixel basis with the image bands at selected wavelengths in the hyperspectral images (Fig 2). A close match would indicate the preservation of spectral characteristics as an indicator of a high probability of success for mildew predictions with a multispectral system scanning at selected wavelengths.

A PLS regression model was developed based spectral data from simulated multispectral images to predict mildew levels in wheat samples. Results were compared with those from the original full-wavelength model (Shahin et al. 2009) and the model using selected narrowband wavelengths.

RESULTS AND DISCUSSION

Wavelength selection

A plot of the PLS regression coefficients of the original fill-wavelength model (Shahin et al. 2009) is shown in Fig 1. Coefficients with a large magnitude indicate important wavelengths of considerable contribution towards the PLS model. As pointed out with arrow, a set of 4 or 5 wavelengths might contain sufficient information to predict mildew levels in wheat samples.

A PLS model built with 4 wavelengths (450, 561, 861 & 917 nm) achieved the maximum performance (Table 1). Adding more wavelengths did not improve the model. The 4-wavelength model performed as well as the original model based on the full-wavelength spectra. $R^2$ and RMSE in both the models were comparable.

Multispectral system simulations

Simulated filter outputs at selected wavelengths were higher in magnitude than corresponding values in the hyperspectral images. Band ratios, however, at selected wavelength were maintained indicating preservation of spectral characteristics. When normalized to the area under the filter response curve, the simulated values closely matched the corresponding target values (Fig 3). Maximum error observed was less than 1%. These results strongly indicated that images captured with a multispectral system would match the corresponding image bands in the hyperspectral images. Next step would be the hardware implementation of the multispectral imaging system.

For hardware implementation of filters, the choice is between using tunable filters or band-pass filters in a motorized filter wheel. Liquid-crystal and Acousto-optic tunable filters (LCTF & AOTF) can be tuned to any wavelength of choice. These are fast but expensive. An LCTF with a wavelength range of 400-1000nm costs approximately $30,000. Band-pass optical filters in a motorized filter wheel offer a relatively slower but much less expensive solution.

CONCLUSIONS

Based on the results of this study it can be concluded that a PLS model using 4 wavelengths can predict mildew levels in wheat samples as accurately as a model using full-spectrum (400-1000nm). Spectral data from a simulated multispectral system match the target hyperspectral data.
for the selected wavelengths within less than 1%. Low cost hardware implementation can be achieved with band-pass filters in a motorized wheel.

REFERENCES


Table 1. Comparison of PLS regression models built with full range spectra and selected wavelengths as model input.

<table>
<thead>
<tr>
<th>PLS model input data</th>
<th>Calibration</th>
<th>Validation</th>
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<tbody>
<tr>
<td></td>
<td>R²</td>
<td>RMSE</td>
</tr>
<tr>
<td>Spectra over the entire wavelength range (450-950nm)</td>
<td>0.893966</td>
<td>0.671744</td>
</tr>
<tr>
<td>Spectra at 4 selected wavelengths</td>
<td>0.890219</td>
<td>0.683511</td>
</tr>
</tbody>
</table>

Figure 1. Regression coefficients for normalized image mean (norm ms) and image standard deviation (stdev) spectra with arrows pointing to 5 selected wavelengths.
Figure 2. Spectral characteristics of the original hyperspectral and simulated multispectral at different areas marked and encircled on the image (A).